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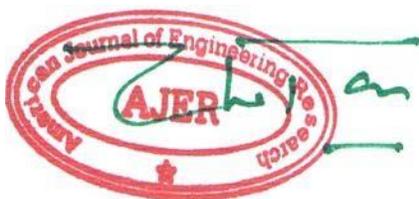
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Editor-In-Chief, AJER  
Mail id: [ajer@editormails.com](mailto:ajer@editormails.com)  
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